

SDAŃSK UNIVERSITY 的 OF TECHNOLOGY

Subject card

Subject name and code	High Frequency Measurement Automation , PG_00048663								
Field of study	Electronics and Telecommunications								
Date of commencement of studies	February 2024		Academic year of realisation of subject			2023/2024			
Education level	second-cycle studies		Subject group			Optional subject group Subject group related to scientific research in the field of study			
Mode of study	Full-time studies		Mode of delivery			at the university			
Year of study	1		Language of instruction			Polish			
Semester of study	1		ECTS credits			2.0			
Learning profile	general academic profile		Assessment form		exam				
Conducting unit	Department of Microwave and Antenna Engineering -> Faculty of Electronics, Telecommunications and Informatics								
Name and surname of lecturer (lecturers)	Subject supervisor		dr hab. inż. Rafał Lech						
	Teachers	dr hab. inż. Rafał Lech							
Lesson types and methods of instruction	Lesson type	Lecture	Tutorial	Laboratory	Project	t	Seminar	SUM	
	Number of study hours	15.0	0.0	15.0	0.0		0.0	30	
	E-learning hours included: 0.0								
Learning activity and number of study hours	Learning activity	Participation in classes include plan	n didactic led in study	Participation in consultation hours		Self-study		SUM	
	Number of study hours	30		4.0		16.0		50	
Subject objectives	Familiarizing yourself with the measurements methods and techniques of basic parameters which are necessary, from a practical point of view, to evaluate the performance of the RF devices and systems.								

Learning outcomes	Course outcome	Subject outcome	Method of verification				
	[K7_W03] Knows and understands, to an increased extent, the construction and operating principles of components and systems related to the field of study, including theories, methods and complex relationships between them and selected specific issues - appropriate for the curriculum.	The student knows the structure of the spectrum analyzer and network analyzer in the full version as well as its simplified implementations and on this basis selects the appropriate calibration method to calibrate the microwave analyzer in the high frequency range and carry out measurements of the basic parameters of RF elements.	[SW1] Assessment of factual knowledge				
	[K7_W06] Knows and understands, to an increased extent, the basic processes taking place in the life cycle of devices, facilities and technical systems.	The student knows the structure of the spectrum analyzer and network analyzer, which allows understanding the principles of their operation and selection of appropriate calibration methods.	[SW1] Assessment of factual knowledge				
	[K7_W04] Knows and understands, to an advanced extent, the principles, methods and techniques of programming and the principles of computer software development or programming devices or controllers using microprocessors or programmable elements or systems specific to the field of study, and organisation of systems using computers or such devices	The student is able to interpret and process measurement results. The student knows the embedding and de-embedding methods that allow the measured object to be embedded into a network of virtually existing systems, or to remove unwanted parts of the measured object from the measurement results.	[SW1] Assessment of factual knowledge				
	[K7_U06] can analyse the operation of components, circuits and systems related to the field of study; measure their parameters; examine technical specifications; interpret obtained results and draw conclusions	The student measures the parameters of single or multiport RF systems, using a network analyzer, spectrum analyzer or reflectometer, and assesses the operation of the measured system based on the obtained results.	[SU4] Assessment of ability to use methods and tools [SU1] Assessment of task fulfilment				
	[K7_U05] can plan and conduct experiments related to the field of study, including computer simulations and measurements; interpret obtained results and draw conclusions	The student is able to choose the appropriate method of network analyzer calibration, he/she can calibrate the microwave analyzer in the high frequency range and perform measurements of basic parameters of RF elements.	[SU4] Assessment of ability to use methods and tools [SU1] Assessment of task fulfilment				
Subject contents	 Measuring equipment Automated measurements of scattering parametres of multiport devices: electronic calibrators, calibration techniques, data processing, time reflectometry Vector network analyzer: measurement capabilities, structure, simplified implementations, calibration Spectrum Analyzers: measurement capabilities, structure, signal sampling techniques, the choice of detector Techniques for locating faults in transmission circuits Techniques to extend the capabilities of measuring microwave network analyzers 						
Prerequisites and co-requisites							
Assessment methods	Subject passing criteria	Passing threshold	Percentage of the final grade				
and criteria	Exam	50.0%	50.0%				
	Lab. reports	50.0%	50.0%				
Recommended reading	Basic literature	1) Christoph Rauscher: "Fundamentals of Spectrum Analysis", Rohde & Schwarz GmbH & Co. KG, 5th Ed., Monachium, 2007 2) Michael Hiebel: "Fundamentals of Vector Network Analysis", Rohde & Schwarz GmbH & Co.KG, 1st Ed., Monachium, 2007					
	Supplementary literature	brak					
	eResources addresses Adresy na platformie eNauczanie: Automatyzacja miernictwa bardzo wysokiej częstotliwości - 23/24 - Moodle ID: 36736 https://enauczanie.pg.edu.pl/moodle/course/view.php?id=36736						
Example issues/ example questions/ tasks being completed	 Briefly compare the advantages and disadvantages of hardware and software reflectometry Time reflectometry in RF measurements Briefly compare electronic and mechanical calibration of vector network analyzer Reflectometric measurement method for measuring reflection parameters. Block diagram of the reflectometer for measuring the modules of reflection and transmission parameters. Calibration techniques of vector network analyzer. Discuss selected reflectometric system to measure reflection parameter. Block diagram and operation of the vector network analyzer. Discuss the selected implementations of simplified vector network analyzer. 						
Work placement	Not applicable						